

Refine Search

Your wildcard search against 10000 terms has yielded the results below.

Your result set for the last L# is incomplete.

The probable cause is use of unlimited truncation. Revise your search strategy to use limited truncation.

Search Results -

Terms	Documents
L1 and (degree\$ near3 similar\$ near5 example\$)	0


Database:

US Pre-Grant Publication Full-Text Database
 US Patents Full-Text Database
 US OCR Full-Text Database
 EPO Abstracts Database
 JPO Abstracts Database
 Derwent World Patents Index
 IBM Technical Disclosure Bulletins

Search:

L8

Refine Search

Recall Text 

Clear

Interrupt

Search History

DATE: Friday, May 12, 2006 [Printable Copy](#) [Create Case](#)

Set Name Query

side by side

Hit Count Set Name

result set

DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=ADJ

<u>L8</u>	11 and (degree\$ near3 similar\$ near5 example\$)	0	<u>L8</u>
<u>L7</u>	12 and L6	1	<u>L7</u>
<u>L6</u>	(visual near5 content near5 example\$)	1	<u>L6</u>
<u>L5</u>	11 and (visual near5 content near5 example\$)	1	<u>L5</u>
<u>L4</u>	11 and (visual near5 content)	133	<u>L4</u>
<u>L3</u>	L2 and (image\$ near5 (index\$ or indice\$))	16	<u>L3</u>
<u>L2</u>	(region\$ or area\$) near7 interest\$ near7 image\$ near7 content	103	<u>L2</u>
<u>L1</u>	(region\$ or area\$) near5 interest\$ near5 image\$	10345	<u>L1</u>

END OF SEARCH HISTORY

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Results for "(((sample* pr example*) and (region* or area*) and interst* and image*)<in>metadata)"

e-mail

Your search matched **0** documents.A maximum of **100** results are displayed, **25** to a page, sorted by **Relevance** in **Descending** order.

» Search Options

[View Session History](#)[New Search](#)

Modify Search

(((sample* pr example*) and (region* or area*) and interst* and image*)<in>metadata

Search >☐ Check to search only within this results set

Display Format:



Citation



Citation & Abstract

» Key

IEEE JNL	IEEE Journal or Magazine
IEE JNL	IEE Journal or Magazine
IEEE CNF	IEEE Conference Proceeding
IEE CNF	IEE Conference Proceeding
IEEE STD	IEEE Standard

No results were found.

Please edit your search criteria and try again. Refer to the Help pages if you need assistance revising your search

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